

Search Notes**Application/Control No.**

10/018,954

Examiner

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Applicant(s)/Patent under Reexamination

YOSHIMINE, TAKAO

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner
715	724	12/9/2005	RFP
Update	Search	5/24/2006	RFP
Update	Search	9/1/2006	RFP
Update	Search	3/2/2007	RFP
Update	Search	8/13/2007	RFP

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/9/2005	RFP
Update Search	5/24/2006	RFP
EAST	5/24/2006	RFP
Update Search	9/1/2006	RFP
IEEE	3/2/2007	RFP
Update Search	3/2/2007	RFP
Update Search	8/13/2007	RFP

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